

HATS = Hall A Trigger Simulation

- Technical Details:

- ♦ General Structure
- ♦ Signal Generation (physics)
- ♦ Signal Processing (electronics)
- ♦ Data analysis

- Results compared with data:

- ♦ Overlap rates
- ♦ Tagger deadtime
- ♦ T1 deadtime

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General Structure

- ROOT/C++ Design;
- A lot of techniques learned from HAMC
- Simulates standard electronics (DAQ).
- Being used by PVDIS. Easy to adapt for other DAQ system.

At every time instance (1ns), **Physics** information is generated. **Detectors** (**Leadglass**, **Gas Cerenkov**, **T1** ...) simulates the detector response and generates signals, which are processed by the **DAQ** system (constructed by **Modules**). **I/O** controls input and output.

classes:

- ◆ hatsPhysics: generates physics.
- ◆ hatsLeadglass, hatsGasCer (abstract class hatsDetector not done yet)
- ◆ hatsModules: abstract class

Derived classes: hatsPhi757, hatsPhi758, hatsSum8, hatsSplitter

- ◆ hatsDAQ: contains physics, detectors, modules, inout.
- ◆ hatsInout: deals with input and output.

General Structure

```
hatsDAQ *DAQ = new hatsDAQ();
```

```
DAQ->Init();
```

```
inout->Init();  
physics->Init();  
leadglass->Init();  
Build();  
Modules Init();
```

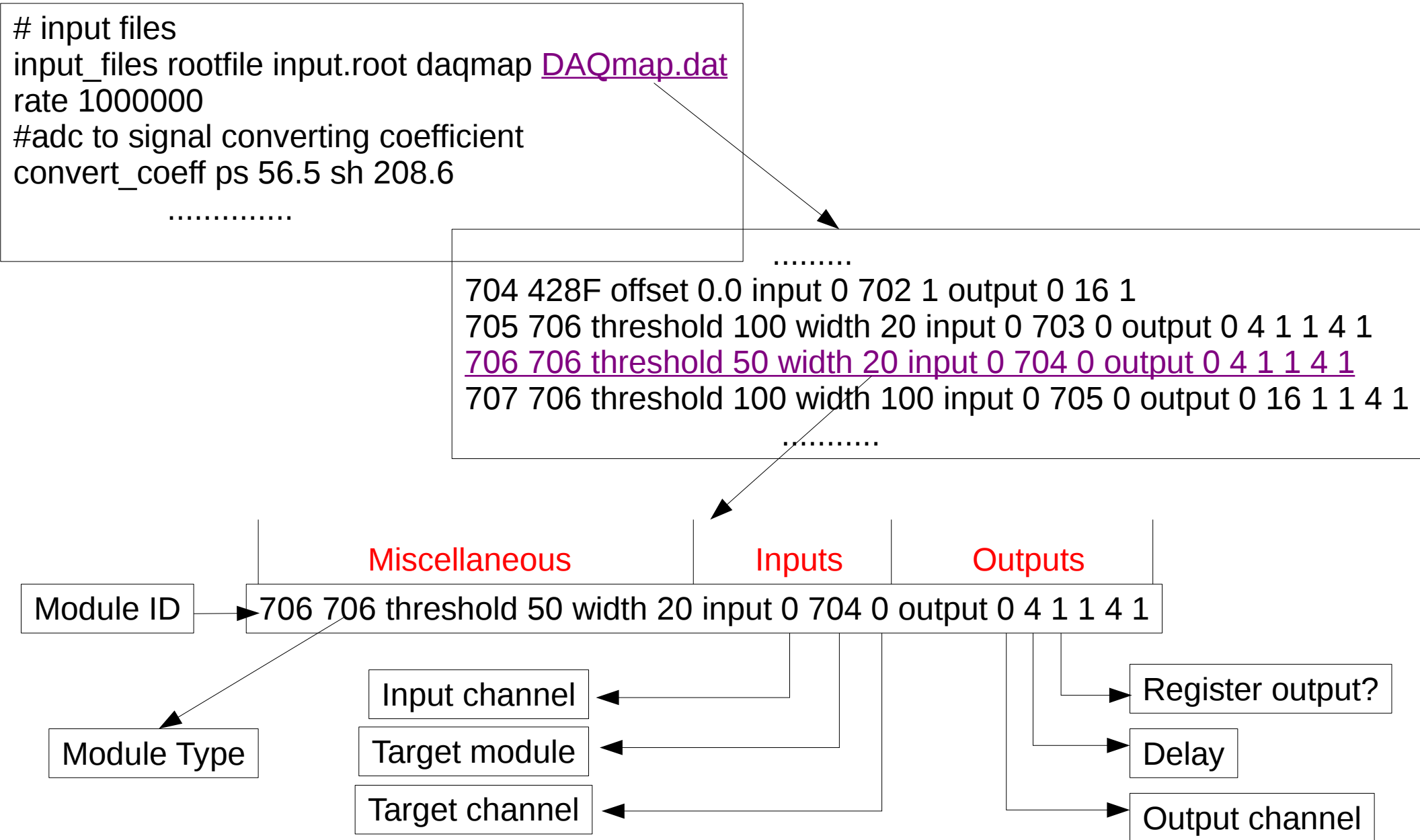
```
CreateModules();  
ConnectModules();  
RegisterOutputs();  
UpdateSequence();
```

```
DAQ->Run(maxtime);
```

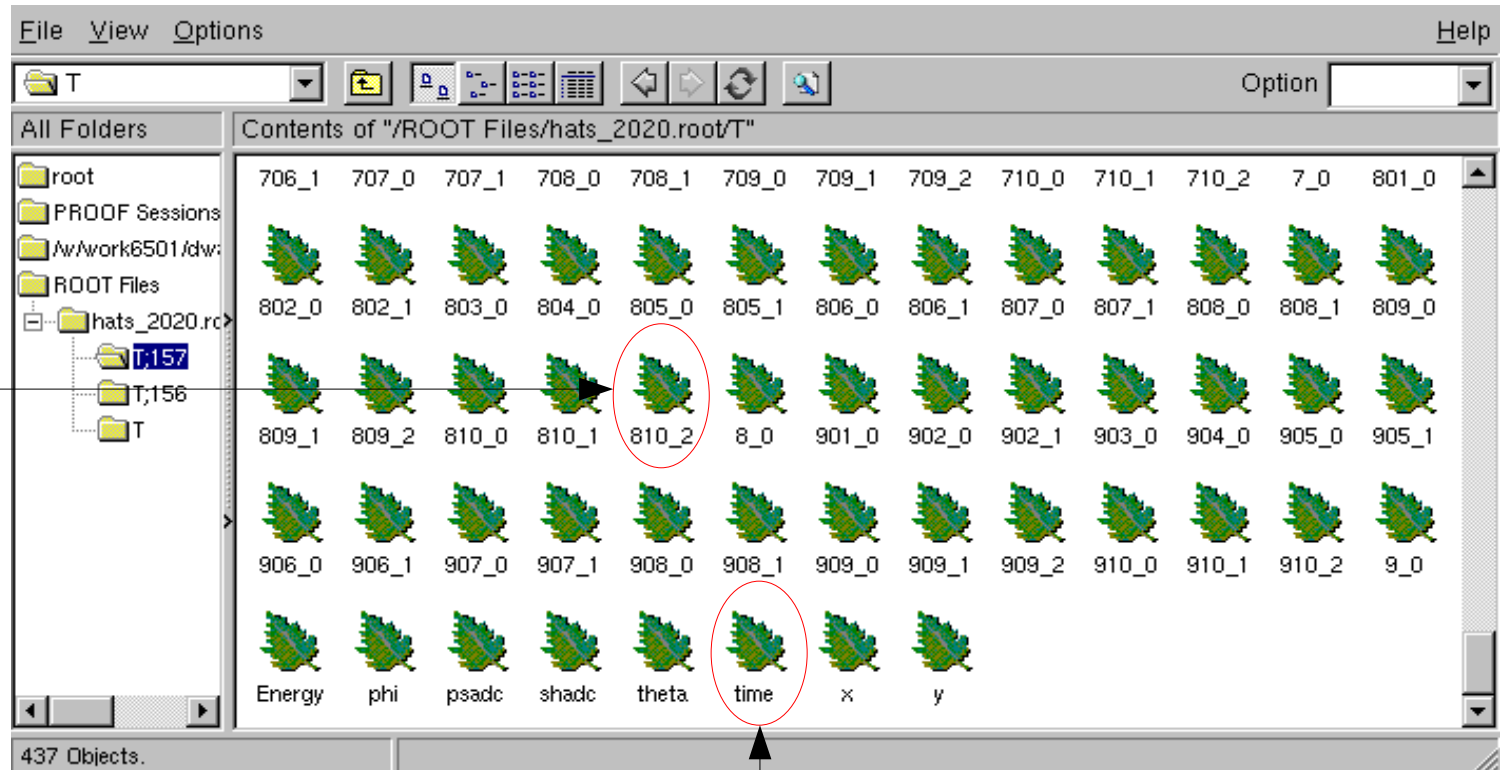
```
for (it = 0; it < maxtime; it++) { //loop over time  
    physics->Generate();  
    leadglass->Generate();  
    for (Int_t j = 0; j < (Int_t) sequence.size(); j++)  
    {  
        Modules[IDmap[sequence[j]]]->Process();  
    }  
    inout->Process();  
}
```

Input and Output

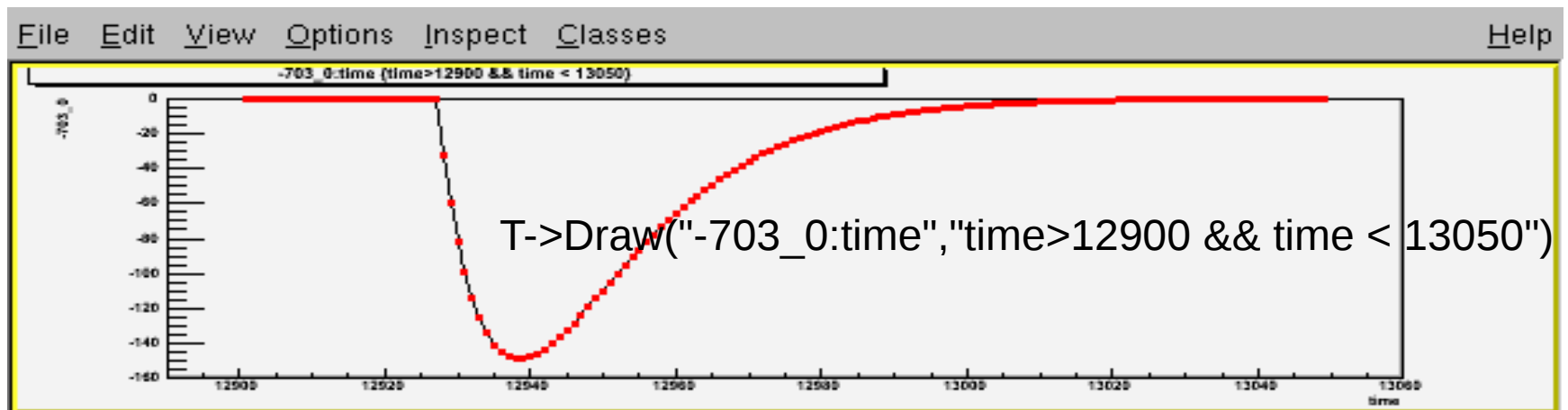
hats.dat:



Input and Output



eg.



Signal Generation

Currently, getting ADC signal from data

Converting coefficients from ADC to analog signal

Analog signal = $A \cdot t \cdot e^{-\frac{t}{\tau}}$, where A is related to energy deposit

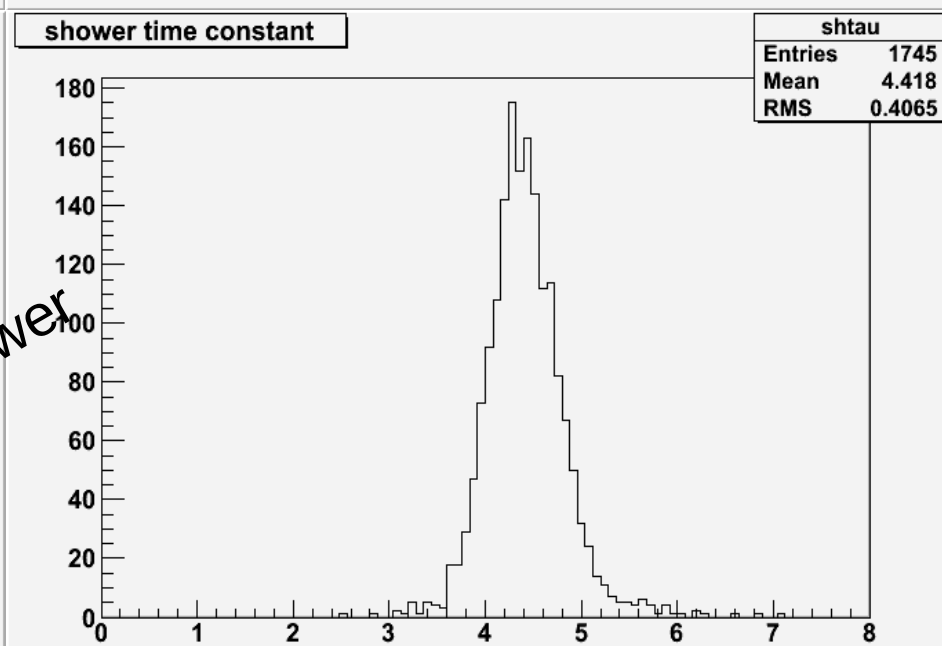
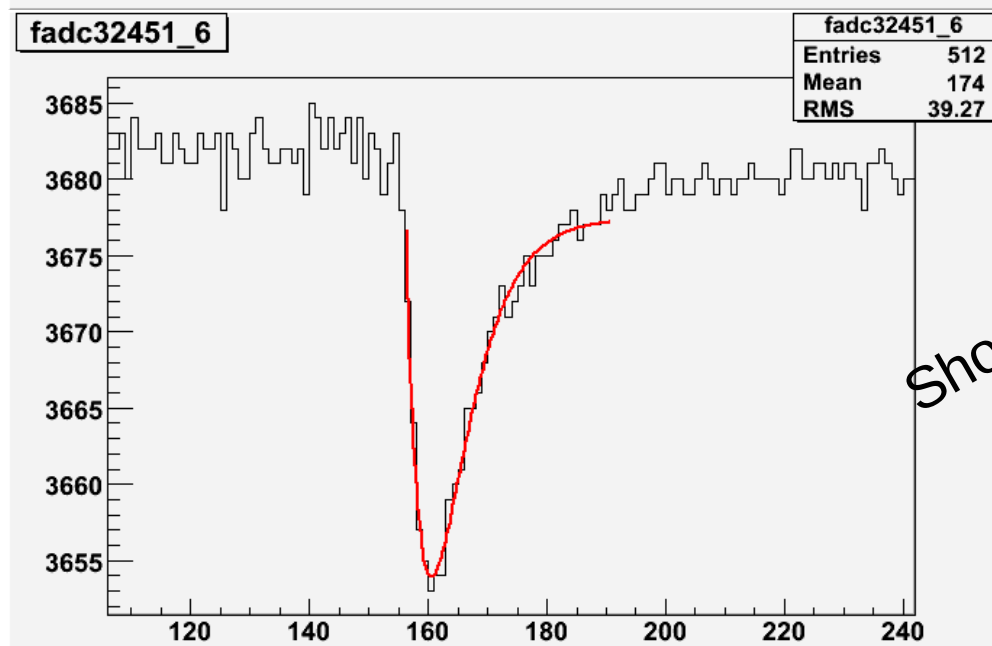
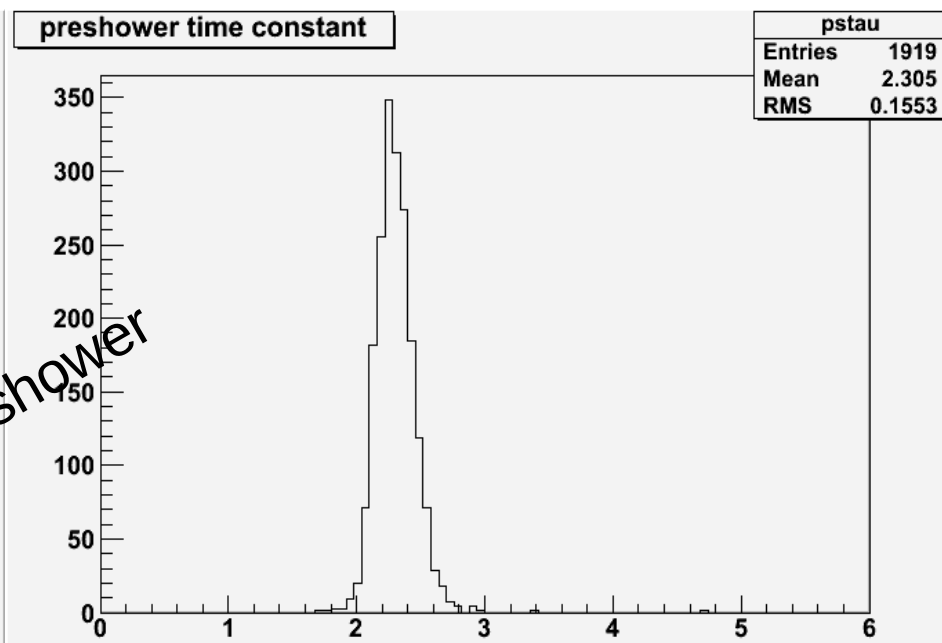
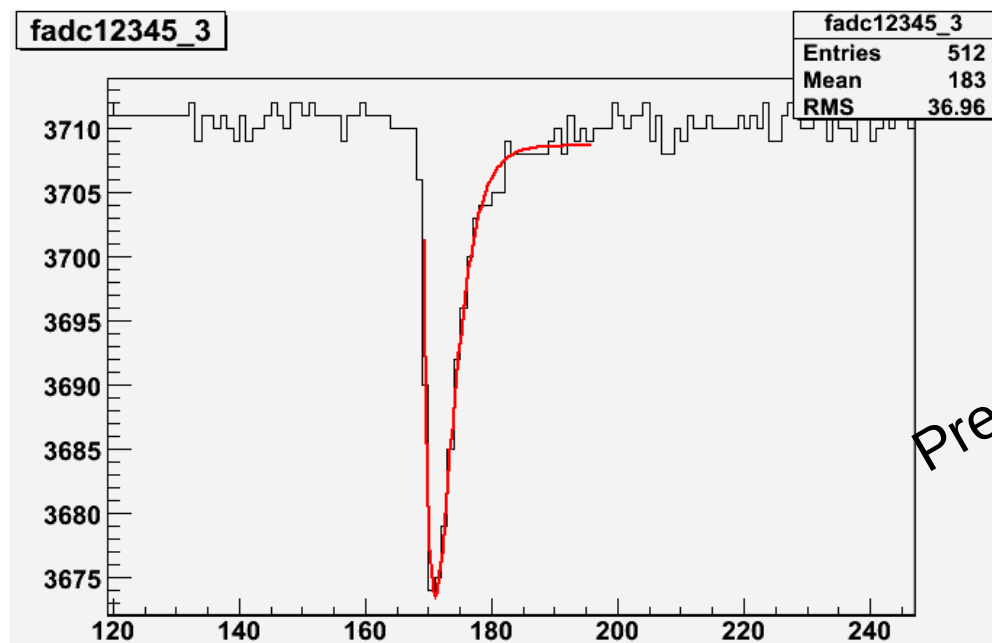
$$threshold = A \cdot \frac{\tau}{e}$$

$$cut\ on\ ADC = k \int A \cdot t \cdot e^{-\frac{t}{\tau}} = k \cdot A \cdot \tau^2$$



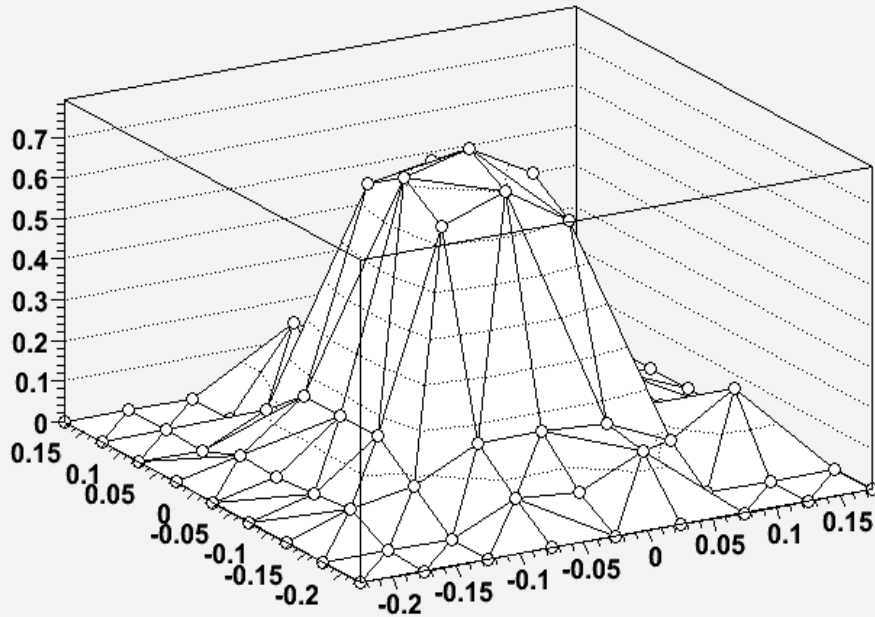
$$k = \frac{cut\ on\ ADC}{e \cdot \tau \cdot threshold}$$

Time Constants: FADC Calibration



Approximately 1x1 cluster

shower ratios



x_cent, y_cent : center of the block i ;
 $x_hit = x_foc + th_foc * drift_sh$;
 $y_hit = y_foc + ph_foc * drift_sh$;
 $Deltax = x_hit - x_cent$;
 $Deltay = y_hit - y_cent$;

$$ratio = \frac{ADC \text{ of block } i}{ADC \text{ total}}$$

3D

Delta y

2D

0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000
0.000	0.000	0.054	0.043	0.035	0.037	0.000	0.000	0.000
0.000	0.000	0.083	0.155	0.155	0.154	0.070	0.000	0.000
0.000	0.073	0.158	0.643	0.714	0.648	0.131	0.205	0.000
0.000	0.061	0.159	0.701	0.768	0.675	0.143	0.066	0.000
0.000	0.133	0.150	0.601	0.666	0.594	0.118	0.105	0.000
0.000	0.000	0.080	0.113	0.119	0.124	0.064	0.000	0.000
0.000	0.000	0.181	0.035	0.037	0.066	0.000	0.000	0.000
0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000

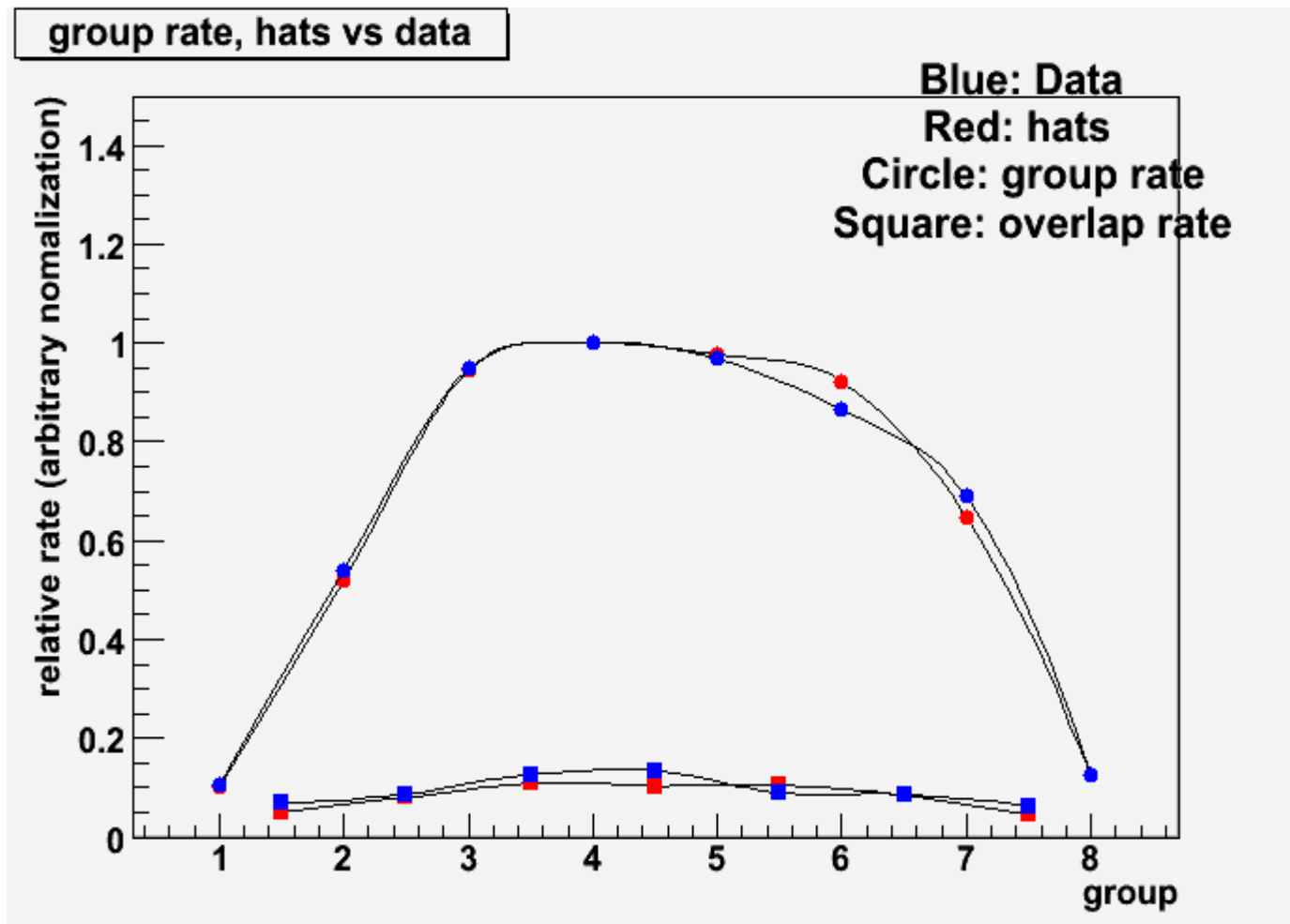
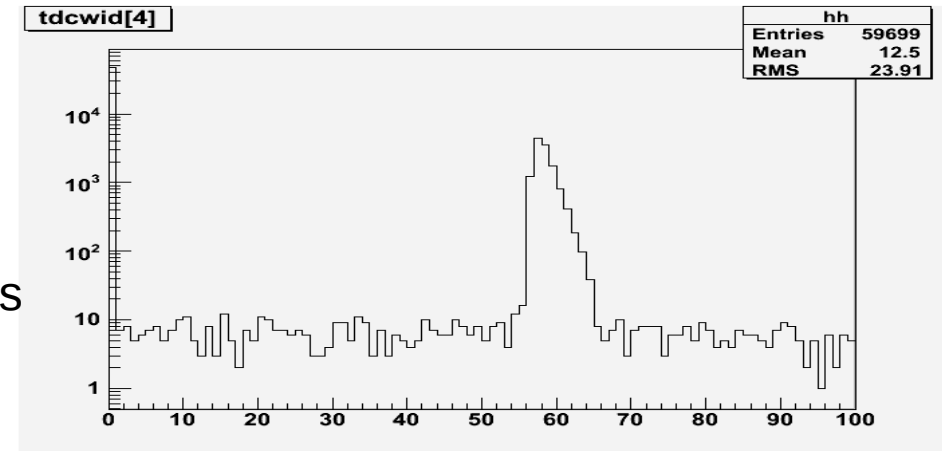
Delta X

Signal Processing

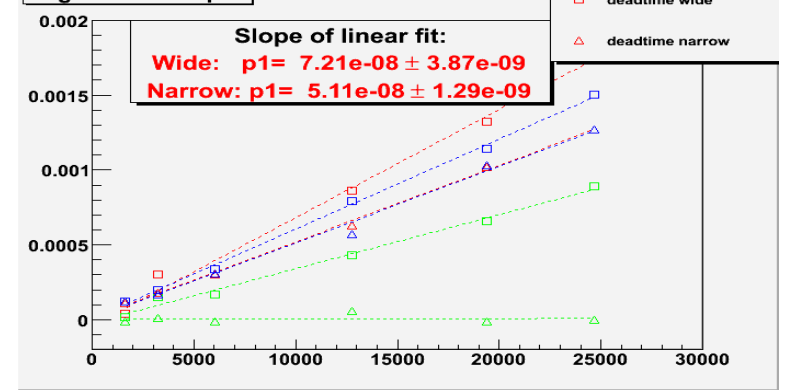
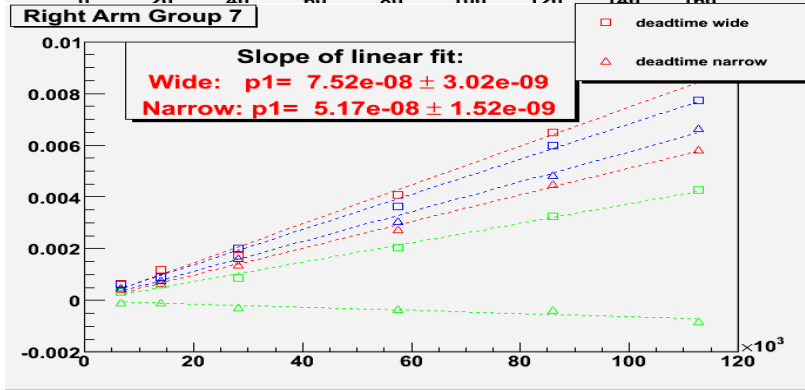
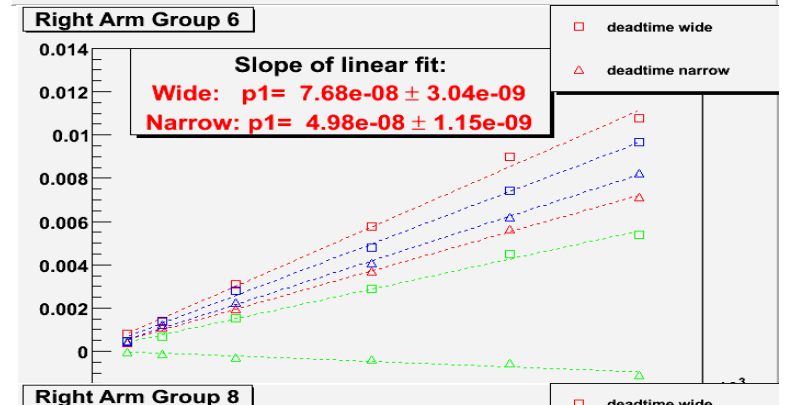
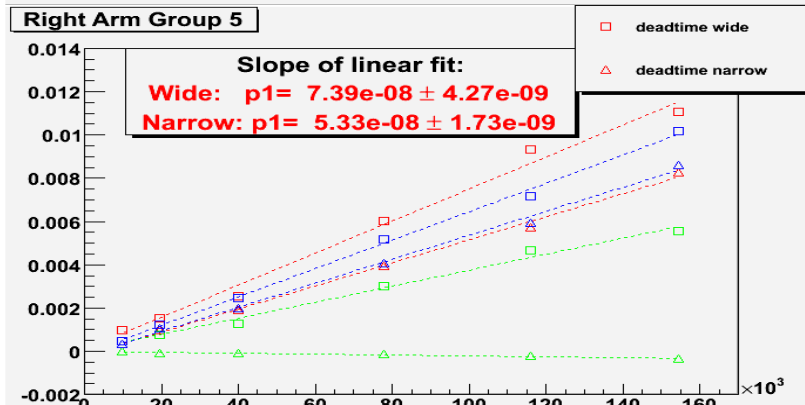
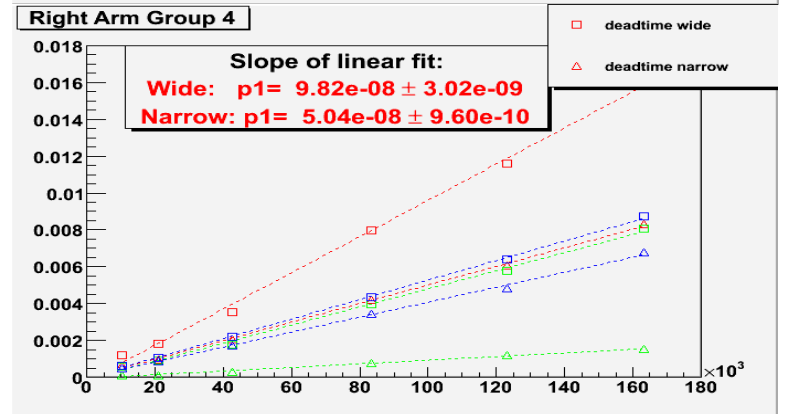
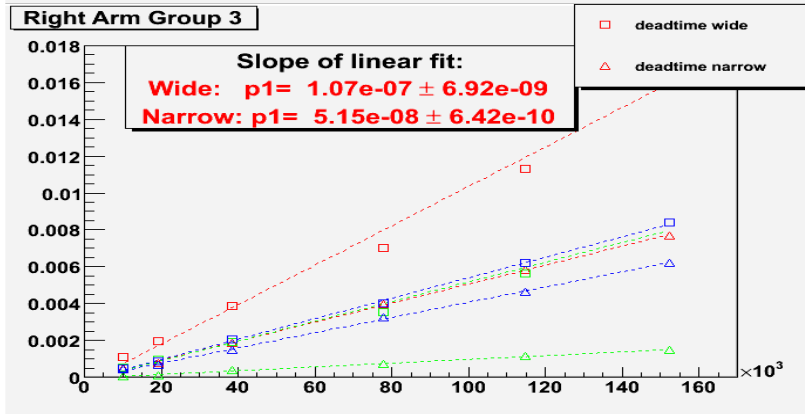
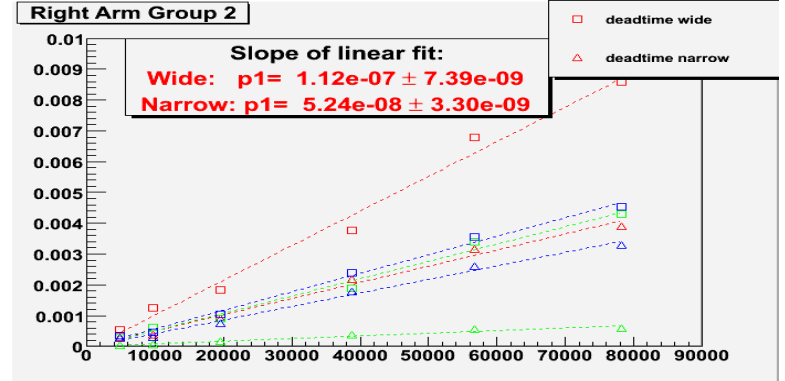
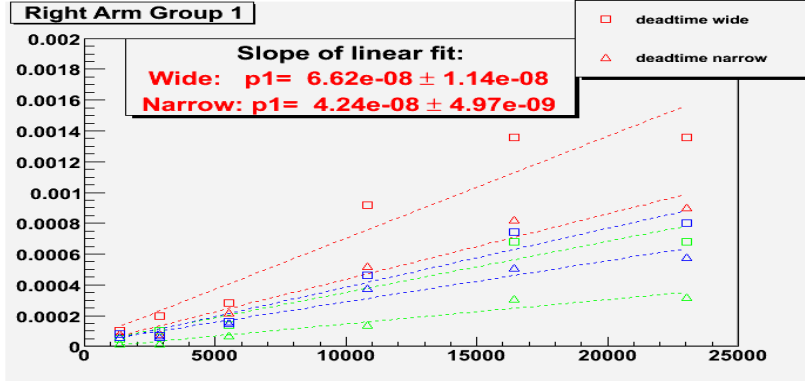
Data Analysis

Overlap rate

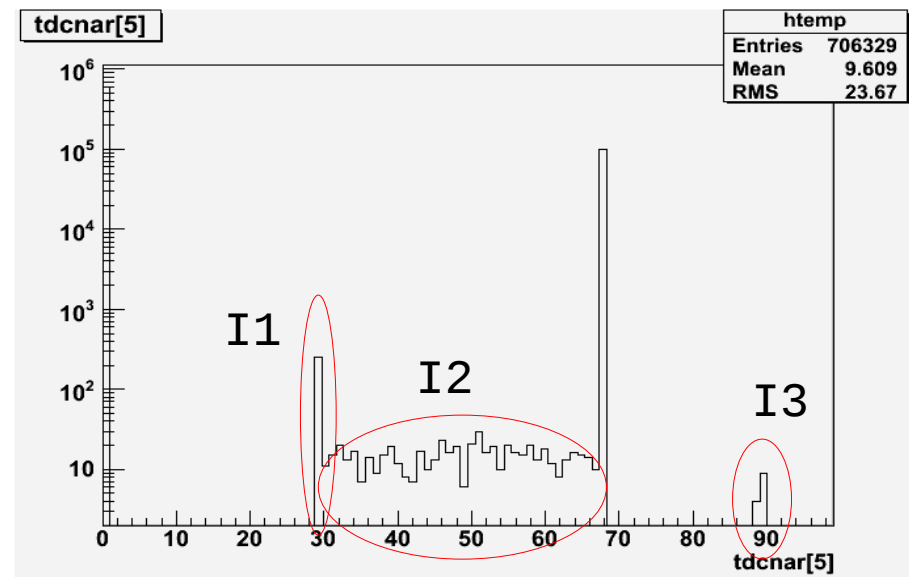
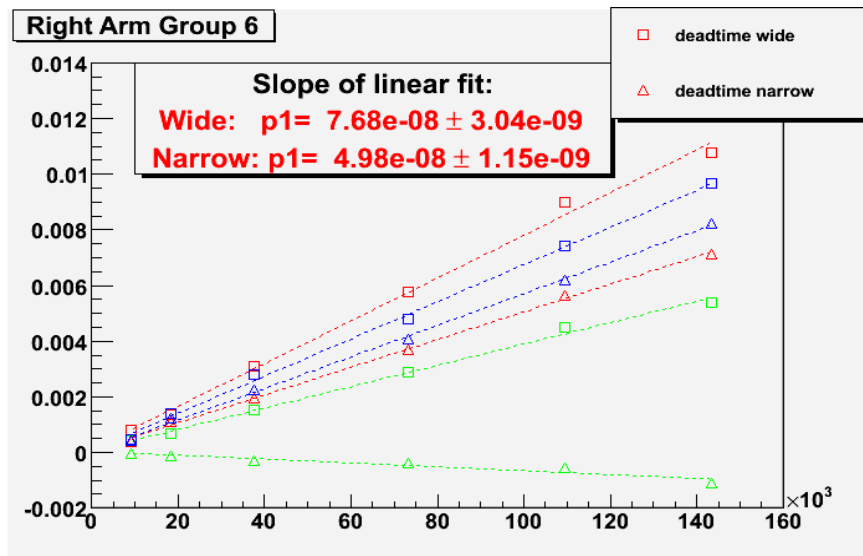
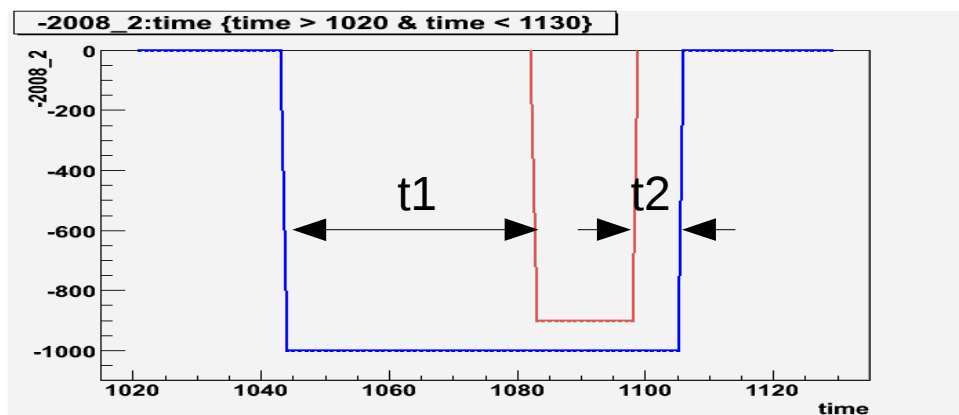
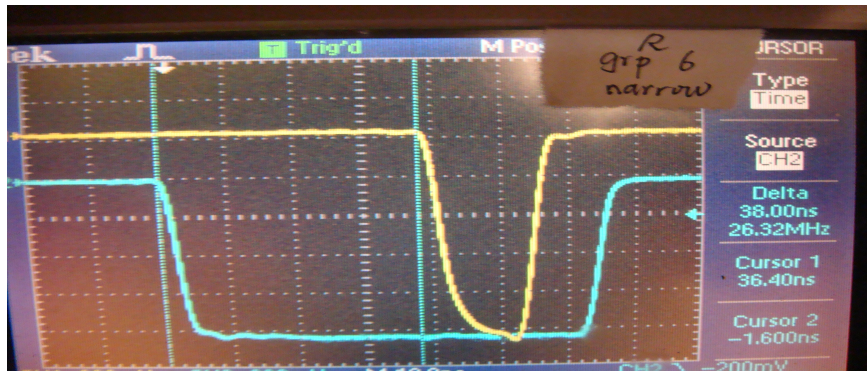
- ◆ Use tdc analysis to get tdc spectrum
- ◆ Cut on the main peak to get group rates
- ◆ Cut on group(i) && group(i+1) to get overlap rates



Tagger Deadtime



Negative Tagger Loss



$I1 = \text{Rate} \times \text{signal width (20 ns)}$

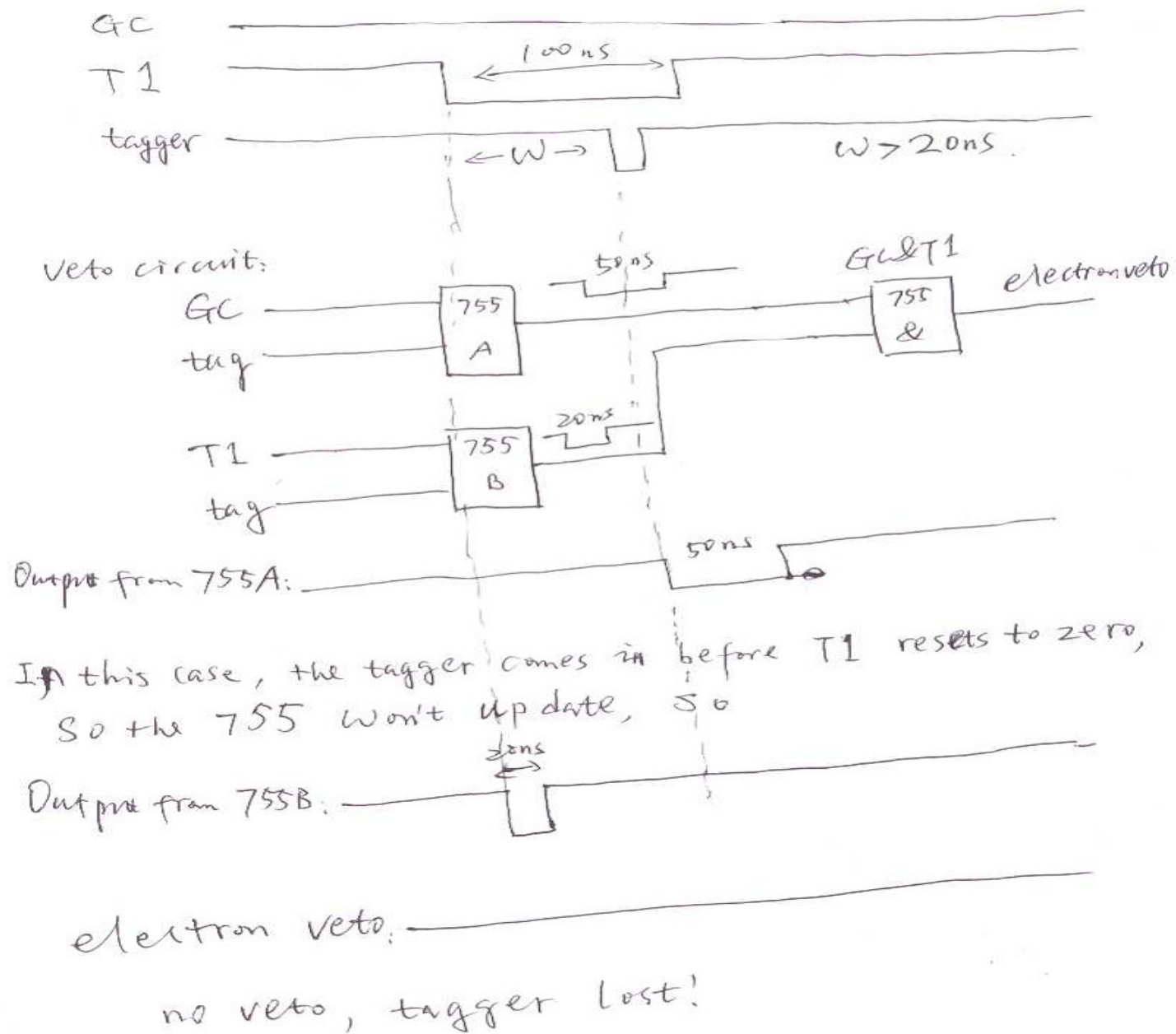
$I2 = \text{Rate} \times t1$

$I3 = \text{Rate} \times t2$

$$(20 + t1 + t2) > \text{path width}$$

Negative tagger loss

T1 Deadtime: Problem revisited



To be continued.....